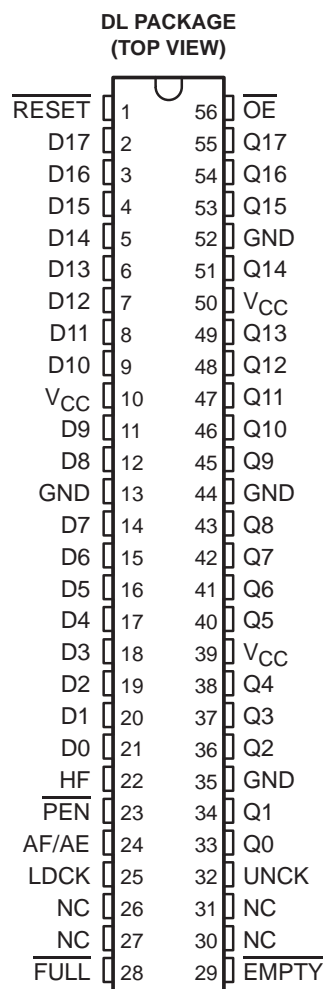


# SN74ACT7814

## 64 × 18 STROBED FIRST-IN, FIRST-OUT MEMORY

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- Member of the Texas Instruments Widebus™ Family
- Load Clock and Unload Clock Can Be Asynchronous or Coincident
- 64 Words by 18 Bits
- Low-Power Advanced CMOS Technology
- Full, Empty, and Half-Full Flags
- Programmable Almost-Full/Almost-Empty Flag
- Fast Access Times of 15 ns With a 50-pF Load and All Data Outputs Switching Simultaneously
- Data Rates up to 50 MHz
- 3-State Outputs
- Pin-to-Pin Compatible With SN74ACT7804 and SN74ACT7806
- Packaged in Shrink Small-Outline 300-mil Package Using 25-mil Center-to-Center Spacing



### description

A FIFO memory is a storage device that allows data to be written into and read from its array at independent data rates. The SN74ACT7814 is a 64-word by 18-bit FIFO for high speed and fast access times. It processes data at rates up to 50 MHz and access times of 15 ns in a bit-parallel format.

Data is written into memory on a low-to-high transition at the load clock (LDCK) input and is read out on a low-to-high transition at the unload clock (UNCK) input. The memory is full when the number of words clocked in exceeds the number of words clocked out by 64. When the memory is full, LDCK signals have no effect on the data residing in memory. When the memory is empty, UNCK signals have no effect.

Status of the FIFO memory is monitored by the full (FULL), empty (EMPTY), half-full (HF), and almost-full/almost-empty (AF/AE) flags. The FULL output is low when the memory is full and high when the memory is not full. The EMPTY output is low when the memory is empty and high when it is not empty. The HF output is high when the FIFO contains 32 or more words and is low when it contains 31 or fewer words. The AF/AE status flag is a programmable flag. The first one or two low-to-high transitions of LDCK after reset are used to program the almost-empty offset value (X) and the almost-full offset value (Y) if program enable (PEN) is low. The AF/AE flag is high when the FIFO contains X or fewer words or (64 – Y) or more words. The AF/AE flag is low when the FIFO contains between (X + 1) and (63 – Y) words.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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# SN74ACT7814

## 64 × 18 STROBED FIRST-IN, FIRST-OUT MEMORY

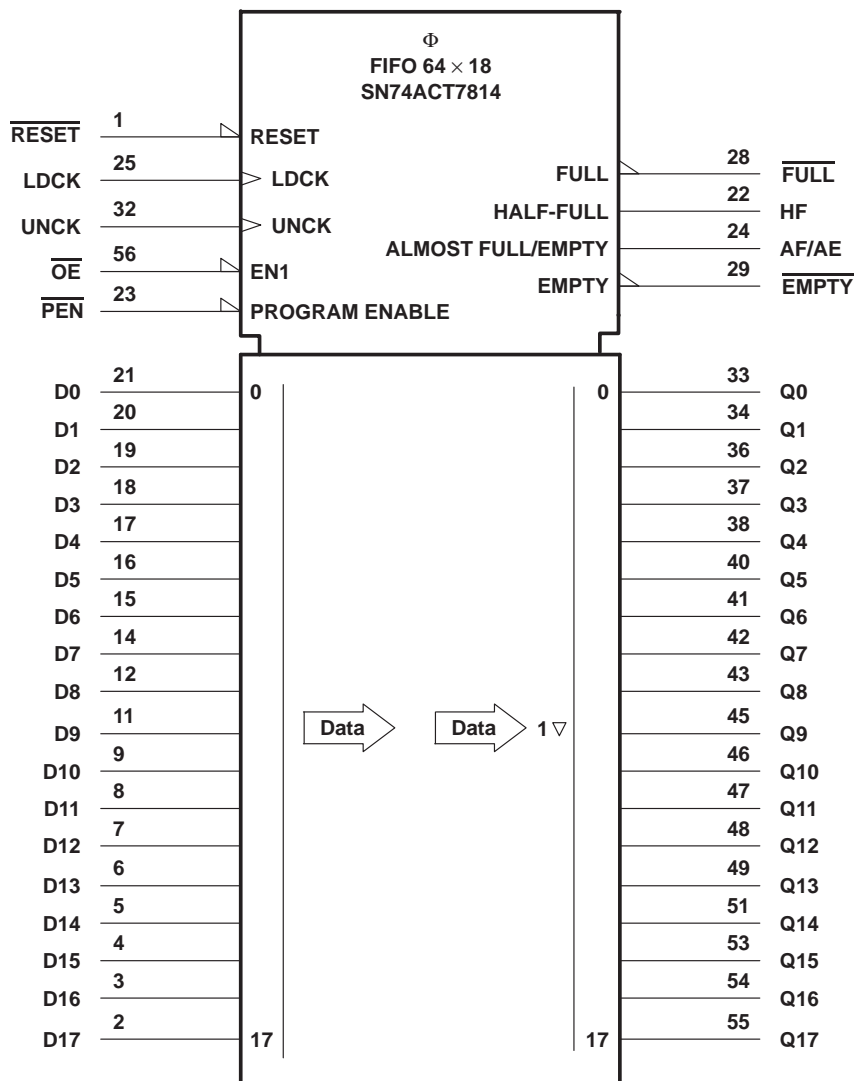
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### description (continued)

A low level on the reset ( $\overline{\text{RESET}}$ ) input resets the internal stack pointers and sets  $\overline{\text{FULL}}$  high, HF low, and  $\overline{\text{EMPTY}}$  low. The Q outputs are not reset to any specific logic level. The FIFO must be reset upon power up. The first word loaded into empty memory causes  $\overline{\text{EMPTY}}$  to go high and the data to appear on the Q outputs. It is important to note that the first word does not have to be unloaded. The data outputs are noninverting with respect to the data inputs and are in the high-impedance state when the output-enable ( $\overline{\text{OE}}$ ) input is high.

The SN74ACT7814 is characterized for operation from 0°C to 70°C.

### logic symbol†



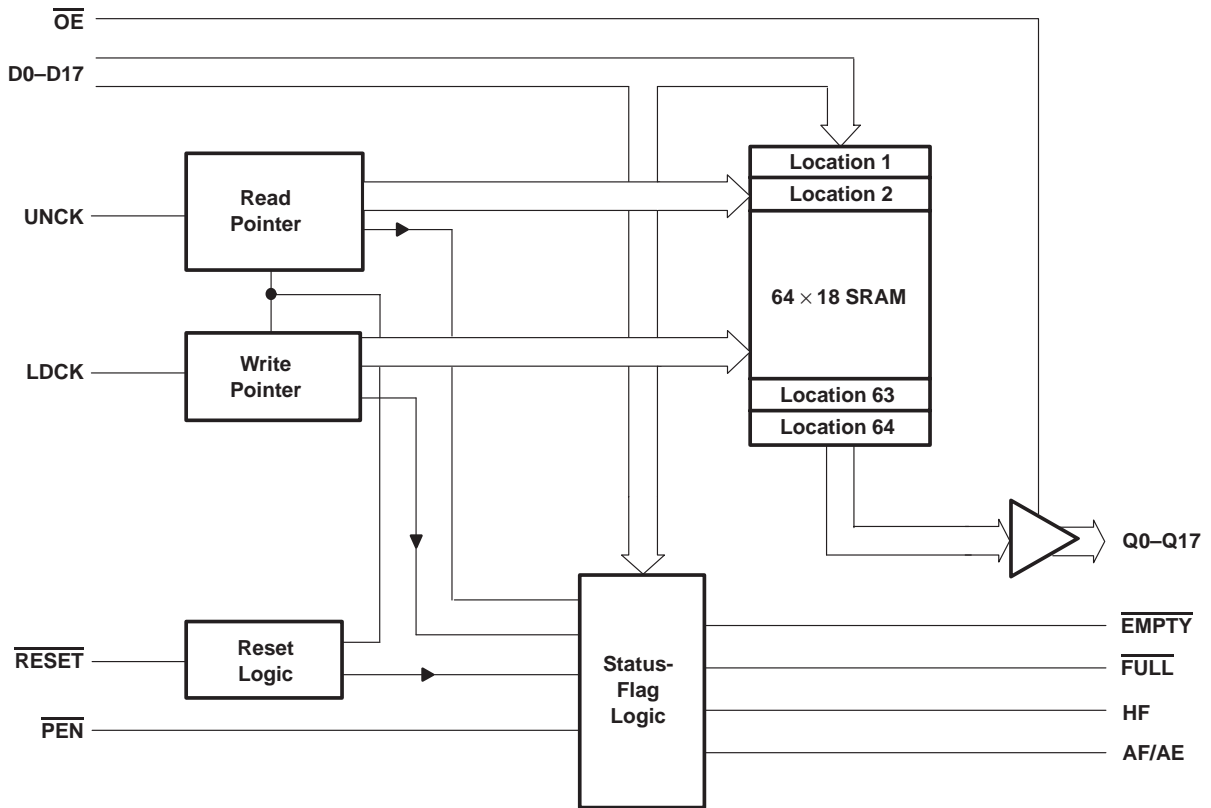
† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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## 64 × 18 STROBED FIRST-IN, FIRST-OUT MEMORY

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### functional block diagram



### Terminal Functions

| TERMINAL NAME             | TERMINAL NO.                          | I/O | DESCRIPTION  |
|---------------------------|---------------------------------------|-----|--|
| AF/AE                     | 24                                    | O   | Almost-full/almost-empty flag. Depth-offset values can be programmed for AF/AE, or the default value of 8 can be used for both the almost-empty offset (X) and the almost-full offset (Y). AF/AE is high when memory contains X or fewer words or (64 - Y) or more words. AF/AE is high after reset. |
| D0-D17                    | 2-9, 11-12, 14-21                     | I   | 18-bit data input port   |
| $\overline{\text{EMPTY}}$ | 29                                    | O   | Empty flag. $\overline{\text{EMPTY}}$ is high when the FIFO memory is not empty; $\overline{\text{EMPTY}}$ is low when the FIFO memory is empty or upon assertion of $\overline{\text{RESET}}$ .   |
| $\overline{\text{FULL}}$  | 28                                    | O   | Full flag. $\overline{\text{FULL}}$ is high when the FIFO memory is not full or upon assertion of $\overline{\text{RESET}}$ ; $\overline{\text{FULL}}$ is low when the FIFO memory is full.  |
| HF                        | 22                                    | O   | Half-full flag. HF is high when the FIFO memory contains 32 or more words. HF is low after reset.  |
| LDCK                      | 25                                    | I   | Load clock. Data is written to the FIFO on the rising edge of LDCK when $\overline{\text{FULL}}$ is high.  |
| $\overline{\text{OE}}$    | 56                                    | I   | Output enable. When $\overline{\text{OE}}$ is high, the data outputs are in the high-impedance state.  |
| $\overline{\text{PEN}}$   | 23                                    | I   | Program enable. After reset and before the first word is written to the FIFO, the binary value on D0-D4 is latched as an AF/AE offset value when $\overline{\text{PEN}}$ is low and WRTCLK is high.  |
| Q0-Q17                    | 33-34, 36-38, 40-43, 45-49, 51, 53-55 | O   | 18-bit data output port  |
| $\overline{\text{RESET}}$ | 1                                     | I   | Reset. A low level on $\overline{\text{RESET}}$ resets the FIFO and drives $\overline{\text{FULL}}$ high and HF and $\overline{\text{EMPTY}}$ low.   |
| UNCK                      | 32                                    | I   | Unload clock. Data is read from the FIFO on the rising edge of UNCK when $\overline{\text{EMPTY}}$ is high.  |



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### offset values for AF/AE

The AF/AE flag has two programmable limits: the almost-empty offset value (X) and the almost-full offset value (Y). They can be programmed after the FIFO is reset and before the first word is written to memory. The AF/AE flag is high when the FIFO contains X or fewer words or (64 – Y) or more words.

To program the offset values,  $\overline{PEN}$  can be brought low after reset only when LDCK is low. On the following low-to-high transition of LDCK, the binary value on D0–D4 is stored as the almost-empty offset value (X) and the almost-full offset value (Y). Holding  $\overline{PEN}$  low for another low-to-high transition of LDCK reprograms Y to the binary value on D0–D4 at the time of the second LDCK low-to-high transition. Writes to the FIFO memory are disabled while the offsets are programmed. A maximum value of 31 can be programmed for either X or Y (see Figure 1). To use the default values of X = Y = 8,  $\overline{PEN}$  must be held high.

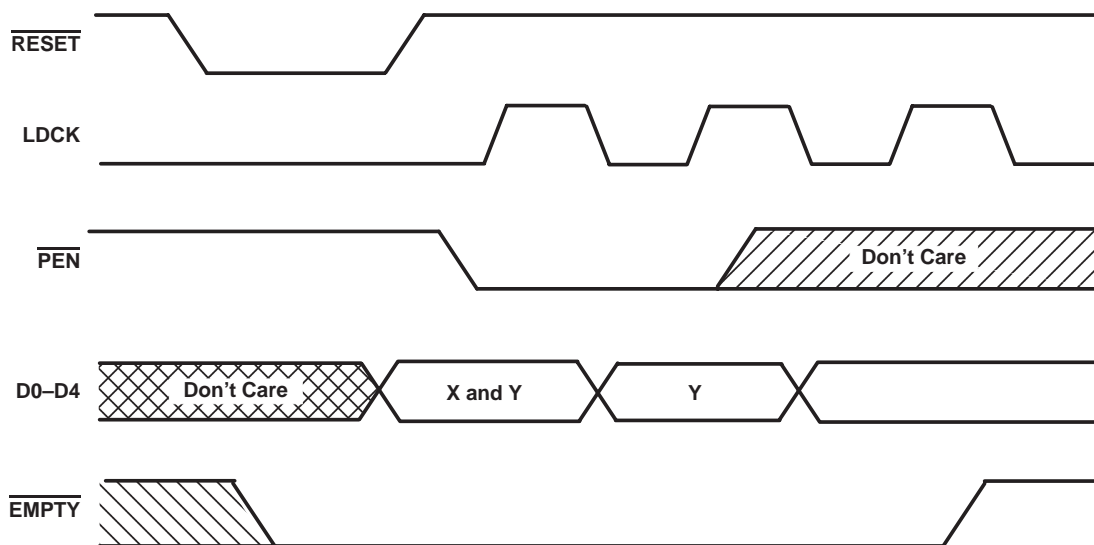


Figure 1. Programming X and Y Separately

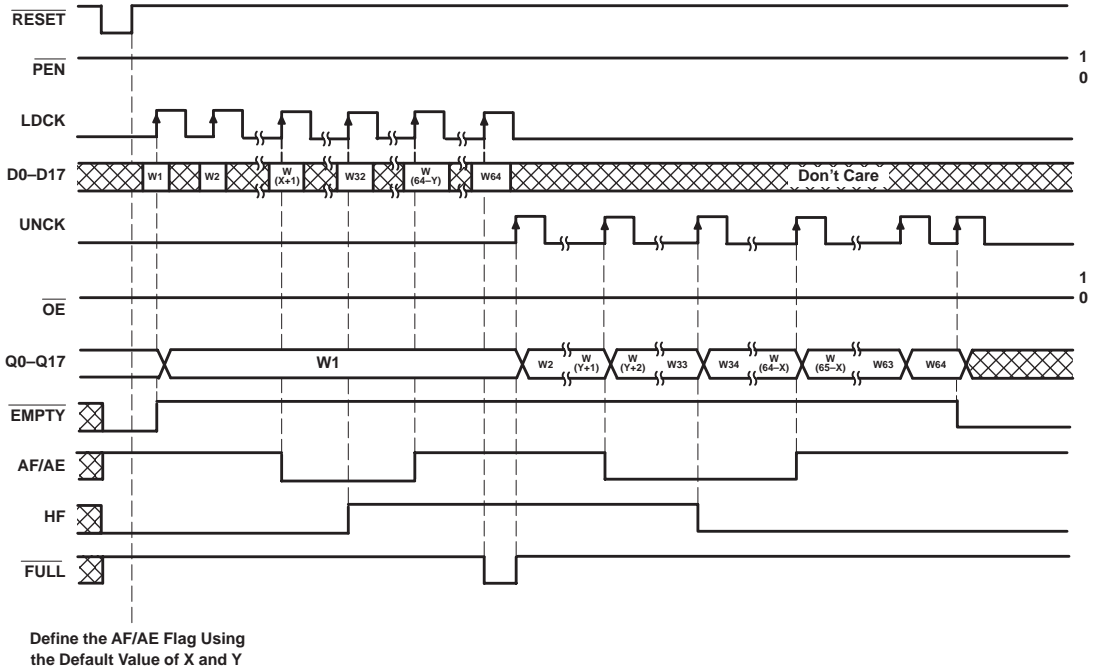


Figure 2. Write, Read, and Flag Timing Reference

# SN74ACT7814

## 64 × 18 STROBED FIRST-IN, FIRST-OUT MEMORY

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

|   |                 |
|---|-----------------|
| Supply voltage range, $V_{CC}$                        | –0.5 V to 7 V   |
| Input voltage range, $V_I$                            | –0.5 V to 7 V   |
| Voltage range applied to a disabled 3-state output    | –0.5 V to 5.5 V |
| Package thermal impedance, $\theta_{JA}$ (see Note 1) | 74°C/W          |
| Storage temperature range, $T_{stg}$                  | –65°C to 150°C  |

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

### recommended operating conditions

|          |                                | 'ACT7814-20      |     | 'ACT7814-25 |     | 'ACT7814-40 |     | UNIT |
|----------|--------------------------------|------------------|-----|-------------|-----|-------------|-----|------|
|          |                                | MIN              | MAX | MIN         | MAX | MIN         | MAX |      |
| $V_{CC}$ | Supply voltage                 | 4.5              | 5.5 | 4.5         | 5.5 | 4.5         | 5.5 | V    |
| $V_{IH}$ | High-level input voltage       | 2                |     | 2           |     | 2           |     | V    |
| $V_{IL}$ | Low-level input voltage        |                  | 0.8 |             | 0.8 |             | 0.8 | V    |
| $I_{OH}$ | High-level output current      | Q outputs, flags |     | –8          | –8  | –8          | –8  | mA   |
| $I_{OL}$ | Low-level output current       | Q outputs        |     | 16          | 16  | 16          | 16  | mA   |
|          |                                | Flags            |     | 8           | 8   | 8           | 8   |      |
| $T_A$    | Operating free-air temperature | 0                | 70  | 0           | 70  | 0           | 70  | °C   |

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER            | TEST CONDITIONS             |   | MIN | TYP‡ | MAX | UNIT |
|----------------------|-----------------------------|---|-----|------|-----|------|
| $V_{OH}$             | $V_{CC} = 4.5$ V,           | $I_{OH} = -8$ mA                                    | 2.4 |      |     | V    |
| $V_{OL}$             | Flags                       | $V_{CC} = 4.5$ V,                                   |     |      | 0.5 | V    |
|                      | Q outputs                   | $V_{CC} = 4.5$ V,                                   |     |      | 0.5 |      |
| $I_I$                | $V_{CC} = 5.5$ V,           | $V_I = V_{CC}$ or 0                                 |     |      | ±5  | μA   |
| $I_{OZ}$             | $V_{CC} = 5.5$ V,           | $V_O = V_{CC}$ or 0                                 |     |      | ±5  | μA   |
| $I_{CC}$             | $V_I = V_{CC} - 0.2$ V or 0 |   |     |      | 400 | μA   |
| $\Delta I_{CC}^{\S}$ | $V_{CC} = 5.5$ V,           | One input at 3.4 V, Other inputs at $V_{CC}$ or GND |     |      | 1   | mA   |
| $C_i$                | $V_I = 0$ ,                 | $f = 1$ MHz   |     | 4    |     | pF   |
| $C_o$                | $V_O = 0$ ,                 | $f = 1$ MHz   |     | 8    |     | pF   |

‡ All typical values are at  $V_{CC} = 5$  V,  $T_A = 25^\circ\text{C}$ .

§ This is the supply current for each input that is at one of the specified TTL voltage levels rather 0 V or  $V_{CC}$ .



# SN74ACT7814

## 64 × 18 STROBED FIRST-IN, FIRST-OUT MEMORY

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### timing requirements over recommended operating conditions (see Figures 1 through 3)

|                    |                 | 'ACT7814-20  |     | 'ACT7814-25 |     | 'ACT7814-40 |     | UNIT |
|--------------------|-----------------|--|-----|-------------|-----|-------------|-----|------|
|                    |                 | MIN  | MAX | MIN         | MAX | MIN         | MAX |      |
| $f_{\text{clock}}$ | Clock frequency | 50   |     | 40          |     | 25          |     | MHz  |
| $t_w$              | Pulse duration  | LDCK high or low                                     |     | 7           | 8   | 12          |     | ns   |
|                    |                 | UNCK high or low                                     |     | 7           | 8   | 12          |     |      |
|                    |                 | $\overline{\text{PEN}}$ low                          |     | 7           | 8   | 12          |     |      |
|                    |                 | $\overline{\text{RESET}}$ low                        |     | 10          | 10  | 12          |     |      |
| $t_{\text{su}}$    | Setup time      | D0–D17 before LDCK $\uparrow$                        |     | 5           | 5   | 5           |     | ns   |
|                    |                 | $\overline{\text{PEN}}$ before LDCK $\uparrow$       |     | 5           | 5   | 5           |     |      |
|                    |                 | LDCK inactive before $\overline{\text{RESET}}$ high  |     | 5           | 6   | 6           |     |      |
| $t_h$              | Hold time       | D0–D17 after LDCK $\uparrow$                         |     | 0           | 0   | 0           |     | ns   |
|                    |                 | LDCK inactive after $\overline{\text{RESET}}$ high   |     | 5           | 6   | 6           |     |      |
|                    |                 | $\overline{\text{PEN}}$ low after LDCK $\uparrow$    |     | 3           | 3   | 3           |     |      |
|                    |                 | $\overline{\text{PEN}}$ high after LDCK $\downarrow$ |     | 0           | 0   | 0           |     |      |

### switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50$ pF (unless otherwise noted) (see Figure 3)

| PARAMETER                | FROM (INPUT)                  | TO (OUTPUT)               | 'ACT7814-20 |               | 'ACT7814-25 |     | 'ACT7814-40 |     | UNIT |     |
|--------------------------|-------------------------------|---------------------------|-------------|---------------|-------------|-----|-------------|-----|------|-----|
|                          |                               |                           | MIN         | TYP $\dagger$ | MAX         | MIN | MAX         | MIN |      | MAX |
| $f_{\text{max}}$         | LDCK or UNCK                  |                           | 50          |               | 40          |     | 25          |     | MHz  |     |
| $t_{\text{pd}}$          | LDCK $\uparrow$               | Any Q                     | 9           |               | 20          | 9   | 22          | 9   | 24   | ns  |
|                          | UNCK $\uparrow$               |                           | 6           | 11.5          | 15          | 6   | 18          | 6   | 20   |     |
| $t_{\text{pd}}^\ddagger$ | UNCK $\uparrow$               | Any Q                     | 10.5        |               |             |     |             |     | ns   |     |
| $t_{\text{PLH}}$         | LDCK $\uparrow$               | $\overline{\text{EMPTY}}$ | 6           |               | 15          | 6   | 17          | 6   | 19   | ns  |
| $t_{\text{PHL}}$         | UNCK $\uparrow$               | $\overline{\text{EMPTY}}$ | 6           |               | 15          | 6   | 17          | 6   | 19   | ns  |
|                          | $\overline{\text{RESET}}$ low |                           | 4           |               | 16          | 4   | 18          | 4   | 20   |     |
|                          | LDCK $\uparrow$               | $\overline{\text{FULL}}$  | 6           |               | 15          | 6   | 17          | 6   | 19   |     |
| $t_{\text{PLH}}$         | UNCK $\uparrow$               | $\overline{\text{FULL}}$  | 6           |               | 15          | 6   | 17          | 6   | 19   | ns  |
|                          | $\overline{\text{RESET}}$ low |                           | 4           |               | 18          | 4   | 20          | 4   | 22   |     |
| $t_{\text{pd}}$          | LDCK $\uparrow$               | AF/AE                     | 7           |               | 18          | 7   | 20          | 7   | 22   | ns  |
|                          | UNCK $\uparrow$               |                           | 7           |               | 18          | 7   | 20          | 7   | 22   |     |
| $t_{\text{PLH}}$         | $\overline{\text{RESET}}$ low | AF/AE                     | 2           |               | 10          | 2   | 12          | 2   | 14   | ns  |
|                          | LDCK $\uparrow$               | HF                        | 5           |               | 18          | 5   | 20          | 5   | 22   |     |
| $t_{\text{PHL}}$         | UNCK $\uparrow$               | HF                        | 7           |               | 18          | 7   | 20          | 7   | 22   | ns  |
|                          | $\overline{\text{RESET}}$ low |                           | 3           |               | 12          | 3   | 14          | 3   | 16   |     |
| $t_{\text{en}}$          | $\overline{\text{OE}}$        | Any Q                     | 2           |               | 9           | 2   | 10          | 2   | 11   | ns  |
| $t_{\text{dis}}$         | $\overline{\text{OE}}$        | Any Q                     | 2           |               | 10          | 2   | 11          | 2   | 12   | ns  |

$\dagger$  All typical values are at  $V_{\text{CC}} = 5$  V,  $T_A = 25^\circ\text{C}$ .

$\ddagger$  This parameter is measured at  $C_L = 30$  pF (see Figure 4).

### operating characteristics, $V_{\text{CC}} = 5$ V, $T_A = 25^\circ\text{C}$

| PARAMETER       |  | TEST CONDITIONS | TYP | UNIT |
|-----------------|--|-----------------|-----|------|
| $C_{\text{pd}}$ | Power dissipation capacitance per FIFO channel | Outputs enabled | 53  | pF   |

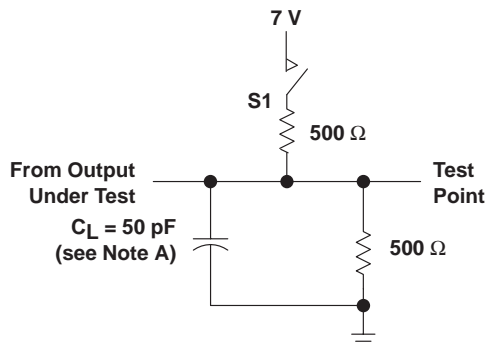


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## 64 × 18 STROBED FIRST-IN, FIRST-OUT MEMORY

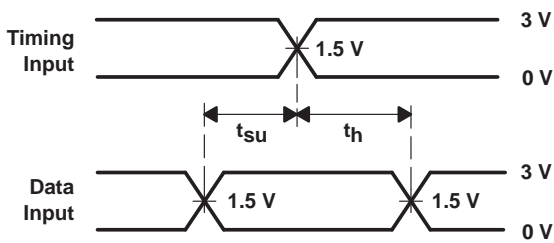
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### PARAMETER MEASUREMENT INFORMATION

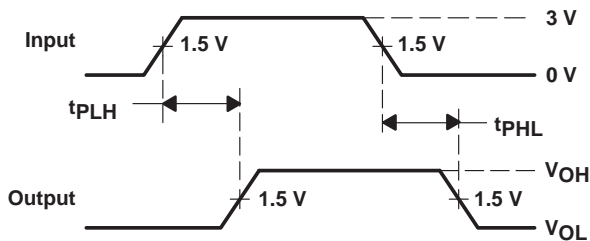


LOAD CIRCUIT

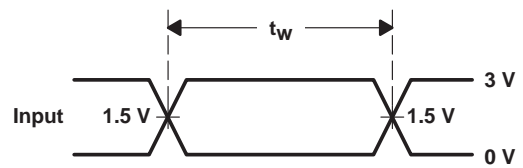
| PARAMETER | S1        |        |
|-----------|-----------|--------|
| $t_{en}$  | $t_{PZH}$ | Open   |
|           | $t_{PZL}$ | Closed |
| $t_{dis}$ | $t_{PHZ}$ | Open   |
|           | $t_{PLZ}$ | Closed |
| $t_{pd}$  | $t_{PLH}$ | Open   |
|           | $t_{PHL}$ | Open   |



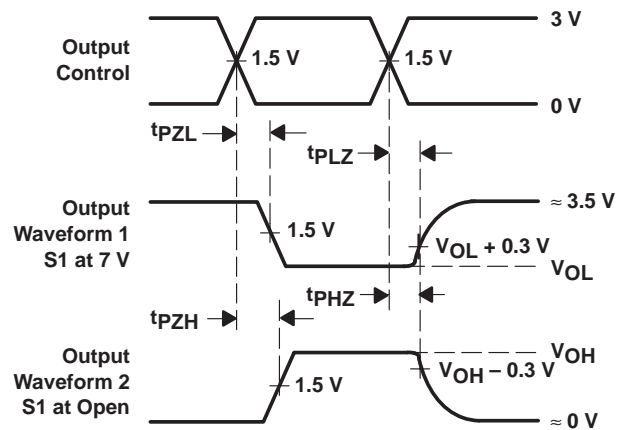
VOLTAGE WAVEFORMS  
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS  
PROPAGATION DELAY TIMES



VOLTAGE WAVEFORMS  
PULSE DURATION



VOLTAGE WAVEFORMS  
ENABLE AND DISABLE TIMES

NOTE A:  $C_L$  includes probe and jig capacitance.

Figure 3. Load Circuit and Voltage Waveforms



TYPICAL CHARACTERISTICS

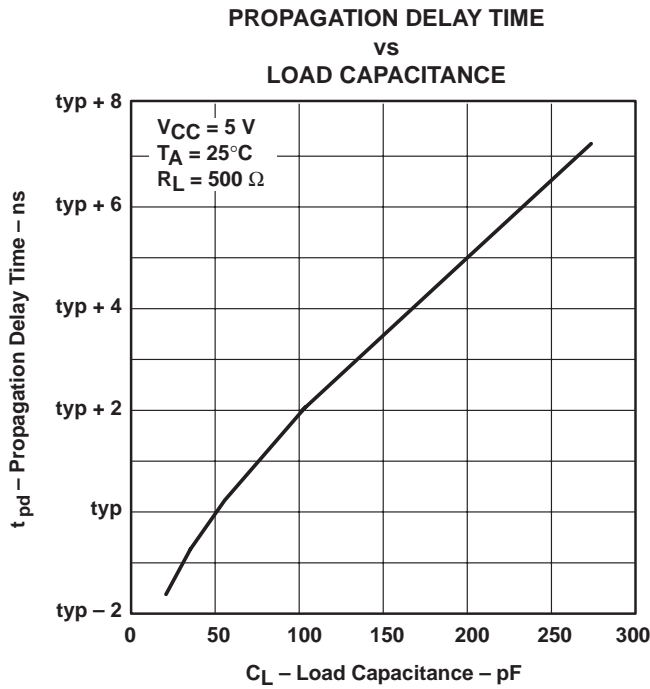


Figure 4

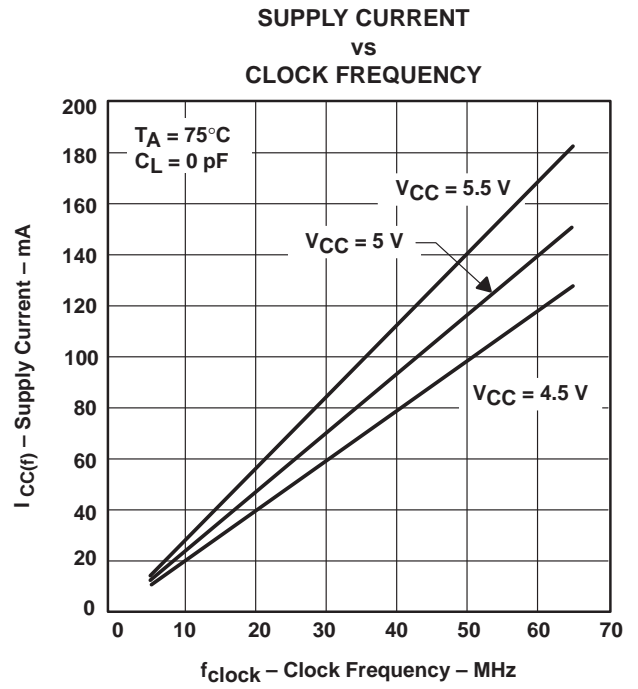


Figure 5

# SN74ACT7814

## 64 × 18 STROBED FIRST-IN, FIRST-OUT MEMORY

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### APPLICATION INFORMATION

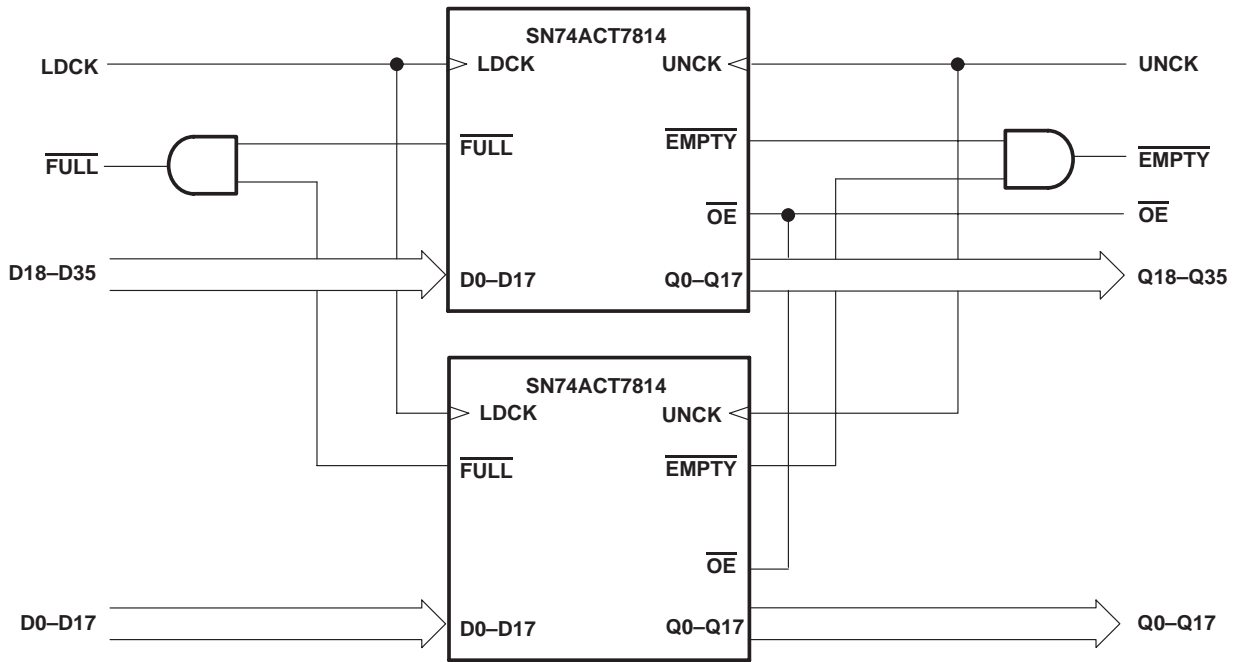


Figure 6. Word-Width Expansion: 64 × 36 Bits

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